- **ADSL Differential Receiver**
 - Ideal for Central Office or Remote **Terminal Applications**
- Low 3.4 mA Per Channel Quiescent Current
- 10 nV/√Hz Voltage Noise
- **Very Low Distortion**
 - THD = -79 dBc (f = 1 MHz, R_1 = 1 k Ω)
- **High Speed**
 - 175 MHz Bandwidth (-3 dB, G = 1)
 - 230 V/μs Slew Rate
- High Output Drive, $I_0 = 85 \text{ mA (typ)}$
- **Wide Range of Power Supplies**
 - $V_{CC} = \pm 5 V \text{ to } \pm 15 V$
- **Available in Standard SOIC or MSOP** PowerPAD™ Package
- **Evaluation Module Available**

THS6072 **D OR DGN PACKAGE** (TOP VIEW) □ ∨_{CC}+ 20UT 1IN+□ 2IN- □ 2IN+ Cross Section View Showing PowerPAD™ Option (DGN)

description

The THS6072 is a high-speed, low-power differential receiver designed for ADSL communication systems. Its low 3.4-mA per channel quiescent current reduces power to half that of other ADSL receivers making it ideal for low power ADSL applications. This receiver operates with a very low distortion of -79 dBc (f = 1 MHz, R_1 = 1 k Ω). The THS6072 is a voltage feedback amplifier offering a high 175-MHz bandwidth and 230-V/μs slew rate and is unity gain stable. It operates over a wide range of power supply voltages including ±4.5 V to ±15 V. This device is available in a standard SOIC or MSOP PowerPAD™ package.

HIGH-SPEED xDSL LINE DRIVER/RECEIVER FAMILY

DEVICE	DRIVER	RECEIVER	5 V	±5 V	±15 V	DESCRIPTION
THS6002	•	•		•	•	500-mA differential line driver and receiver
THS6012	•			•	•	500-mA differential line driver
THS6022	•			•	•	250-mA differential line driver
THS6032	•			•	•	500-mA low-power ADSL central-office line driver
THS6042/3	•			•	•	350-mA, ±12 V ADSL CPE Line Drivers
THS6052/3	•			•	•	100-mA, ±12 V ADSL CPE Line Drivers
THS6062		•	•	•	•	Low-noise ADSL receiver
THS6072		•		•	•	Low-power ADSL receiver
THS6092/3	•		•	•		200-mA, ±12 V ADSL CPE Line Drivers
THS7002		•		•	•	Low-noise programmable-gain ADSL receiver



CAUTION: The THS6072 provides ESD protection circuitry. However, permanent damage can still occur if this device is subjected to high-energy electrostatic discharges. Proper ESD precautions are recommended to avoid any performance degradation or loss of functionality.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PowerPAD is a trademark of Texas Instruments.



AVAILABLE OPTIONS

		PACKAGED DEVICES			
TA	NUMBER OF CHANNELS	PLASTIC SMALL OUTLINE [†] (D)	PLASTIC MSOP† (DGN)	MSOP SYMBOL	EVALUATION MODULE
0°C to 70°C	2	THS6072CD	THS6072CDGN	AHZ	THS6072EVM
-40°C to 85°C	2	THS6072ID	THS6072IDGN	AIA	_

[†]The D and DGN packages are available taped and reeled. Add an R suffix to the device type (i.e., THS6072CDGN).

functional block diagram

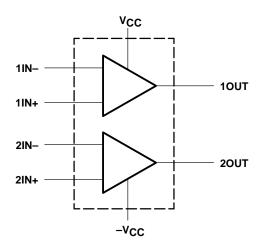


Figure 1. THS6072 - Dual Channel



absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V _{CC}		±16.5 V
		±V _{CC}
		150 mA
Differential input voltage, V _{IO}		±4 V
Continuous total power dissipation		See Dissipation Rating Table
Maximum junction temperature, T _J		
Operating free-air temperature, T _A :	C-suffix	0°C to 70°C
	I-suffix	–40°C to 85°C
Storage temperature, T _{stg}		65°C to 150°C
Lead temperature 1,6 mm (1/16 inch	n) from case for 10 seconds	300°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	θJA (°C/W)	θJC (°C/W)	T _A = 25°C POWER RATING
D	167‡	38.3	740 mW
DGN§	58.4	4.7	2.14 W

[†]This data was taken using the JEDEC standard Low-K test PCB. For the JEDEC Proposed High-K test PCB, the θ_{JA} is 95°C/W with a power rating at $T_A = 25$ °C of 1.32 W.

recommended operating conditions

		MIN	NOM MAX	UNIT
Supply voltage Vac and Vac	Dual supply	±4.5	±16	.,
Supply voltage, V _{CC+} and V _{CC-}	Single supply	9	32]
Operating free pir temperature. To	C-suffix	0	70	°C
Operating free-air temperature, TA	I-suffix	-40	85	1

[§] This data was taken using 2 oz. trace and copper pad that is soldered directly to a 3 in. \times 3 in.

PC. For further information, refer to Application Information section of this data sheet.

electrical characteristics at T_A = 25°C, V_{CC} = \pm 15 V, R_L = 150 Ω (unless otherwise noted)

dynamic performance

	PARAMETER	TI	EST CONDITIONS		MIN TYP	MAX	UNIT	
		V _{CC} = ±15 V	$V_{CC} = \pm 15 \text{ V}$		175		MHz	
	Small-signal bandwidth (–3 dB)	V _{CC} = ±5 V		Gain = 1	160		IVITZ	
	Small-signal bandwidth (–3 db)	$V_{CC} = \pm 15 \text{ V}$		Gain = -1	70		MHz	
BW		V _{CC} = ±5 V		Gain = -1	65		IVITZ	
D VV	Bandwidth for 0.1 dB flatness	$V_{CC} = \pm 15 \text{ V}$		Gain = 1	35		MHz	
	Daridwidth for 0.1 db flatfless	V _{CC} = ±5 V		Gaill = 1	35		IVIITZ	
	Full power bandwidth [†]	$V_{O(pp)} = 20 \text{ V},$	$V_{CC} = \pm 15 \text{ V}$		2.7		MHz	
	ruii powei balluwidiiii	$V_{O(pp)} = 5 V,$	$V_{CC} = \pm 5 V$		7.1		IVITZ	
SR	Slew rate [‡]	$V_{CC} = \pm 15 \text{ V},$	20-V step	Gain = 5	230		V/μs	
SK	Siew later	$V_{CC} = \pm 5 \text{ V},$	5-V step	Gain = 1	170		ν/μδ	
	Settling time to 0.1%	$V_{CC} = \pm 15 \text{ V},$	5-V step	Gain = −1	43		ns	
١.	Settling time to 0.1%	$V_{CC} = \pm 5 \text{ V},$	2-V step	Gairr = -1	30		115	
t _S	Settling time to 0.01%	$V_{CC} = \pm 15 \text{ V},$	5-V step	Gain = −1	233		ne	
	Setting time to 0.01%	$V_{CC} = \pm 5 \text{ V},$	2-V step	Gaiii = -1	280		ns	

noise/distortion performance

	PARAMETER	TEST	CONDITIONS		MIN	TYP	MAX	UNIT
THD	Total harmonic distortion	V _{O(pp)} = 2 V, f = 1 MHz, Gain = 2	$V_{CC} = \pm 15 \text{ V}$	$R_L = 1 k\Omega$		-79		dBc
טחו	iotai naimonic distortion	f = 1 MHz, Gain = 2	$V_{CC} = \pm 5 \text{ V}$	$R_L = 1 k\Omega$		-77		UDC
٧n	Input voltage noise	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V},$	f = 10 kHz			10		nV/√ Hz
In	Input current noise	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V},$	f = 10 kHz			0.7		pA/√Hz
	Channel-to-channel crosstalk	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V},$	f = 1 MHz			-75		dB

dc performance

	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
		Voc = +15 V Vo = +10 V Pr = 1 k0	T _A = 25°C	10	19		V/mV
	Open loop gain	$V_{CC} = \pm 15 \text{ V}, V_{O} = \pm 10 \text{ V}, R_{L} = 1 \text{ k}\Omega$	T _A = full range	9			V/IIIV
	Орен юор дан	$V_{CC} = \pm 5 \text{ V}, V_{O} = \pm 2.5 \text{ V}, R_{I} = 250 \Omega$	T _A = 25°C	8	16		V/mV
		$VCC = \pm 3$ V, $VC = \pm 2.5$ V, $RC = 250$ Ω	T _A = full range	7			V/IIIV
V00	Input offset voltage		T _A = 25°C		1	7	mV
Vos	input onset voltage		T _A = full range			8	IIIV
	Offset voltage drift		T _A = full range		15		μV/°C
in	Input bias current	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	T _A = 25°C		1.2	6	μА
¹IB	input bias current		T _A = full range			8	μΑ
loo	Input offset current		T _A = 25°C		20	250	nA
los	input onset current		T _A = full range			400	ПА
	Offset current drift	T _A = full range			0.3	·	nA/°C

[†] Full power bandwidth = slew rate/2π V_O(Peak). ‡ Slew rate is measured from an output level range of 25% to 75%.

electrical characteristics at T_A = 25 °C, V_{CC} = ± 15 V, R_L = 150 Ω (unless otherwise noted) (continued)

input characteristics

	PARAMETER	Т	EST CONDITIONS	1	MIN	TYP	MAX	UNIT
\/.op	Common-mode input voltage range	$V_{CC} = \pm 15 \text{ V}$			±13.8	±14.1		V
VICR	Common-mode input voltage range	$V_{CC} = \pm 5 \text{ V}$			±3.8	±3.9		V
CMRR	Common mode rejection ratio	$V_{CC} = \pm 15 \text{ V},$	$V_{ICR} = \pm 12 V$,	$T_A = \text{full range}$	78	90		dB
CIVIKK	Common mode rejection ratio	$V_{CC} = \pm 5 \text{ V},$	$V_{ICR} = \pm 2 V$,	T _A = full range	84	93		dB
R _I	Input resistance					1		МΩ
Cl	Input capacitance		_			1.5		pF

output characteristics

	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
		$V_{CC} = \pm 15 \text{ V}$	$R_L = 250 \Omega$	±12	±13.6		V
\ _{\\} _	V- Output voltage eving	$V_{CC} = \pm 5 \text{ V}$	$R_L = 150 \Omega$	±3.4	±3.8		V
۷o	Output voltage swing	V _{CC} = ±15 V	B: -1k0	±13	±13.8		V
		V _{CC} = ±5 V	$R_L = 1 k\Omega$	±3.5	±3.9		V
la	Outrot summent	V _{CC} = ±15 V	R ₁ = 20 Ω	65	85		mA
10	Output current [†]	$V_{CC} = \pm 5 \text{ V}$	KL = 20 12	50	70		ША
Isc	Short-circuit current [†]	V _{CC} = ±15 V			100		mA
RO	Output resistance	Open loop			13	, and the second	Ω

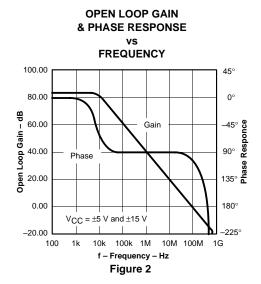
[†] Observe power dissipation ratings to keep the junction temperature below the absolute maximum rating when the output is heavily loaded or shorted. See the absolute maximum ratings section of this data sheet for more information.

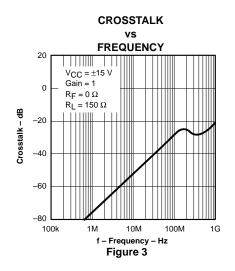
power supply

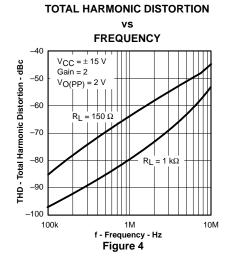
	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
V	Supply voltage operating range	Dual supply		±4.5		±16.5	V
Vcc	Supply voltage operating range	Single supply		9		33	V
		V +45.V	T _A = 25°C		3.4	4.2	
,	Cumply ourrest (nor complifier)	V _{CC} = ±15 V	T _A = full range			5	A
Icc	Supply current (per amplifier)	Voc. 15 V	T _A = 25°C		2.9	3.7	mA
		VCC = ±5 V	T _A = full range			4.5	
PSRR	Power supply rejection ratio	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	T _A = full range	79	90		dB

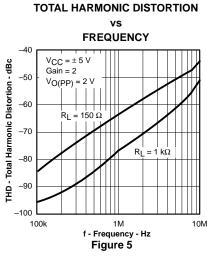
NOTE: Full range = 0° C to 70° C for C suffix and -40° C to 85° C for I suffix

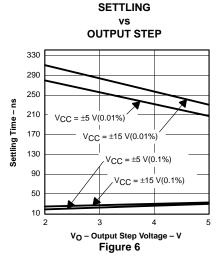


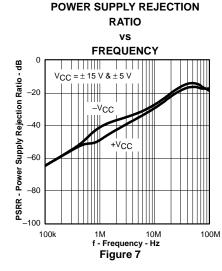


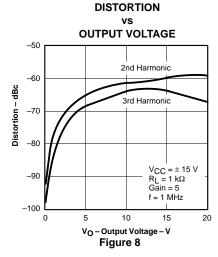


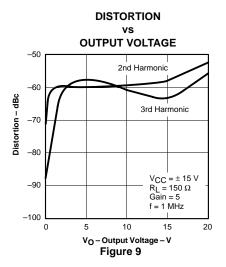


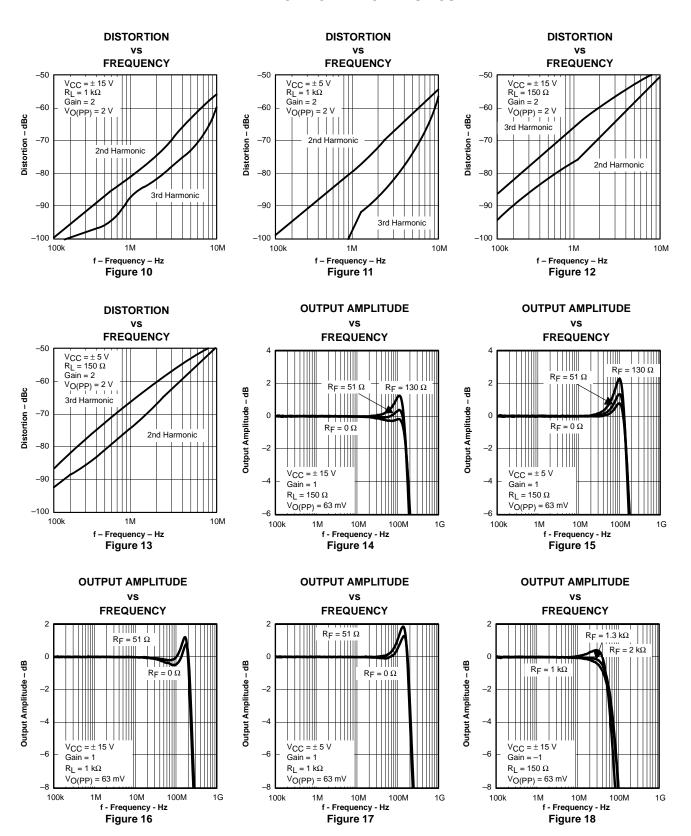














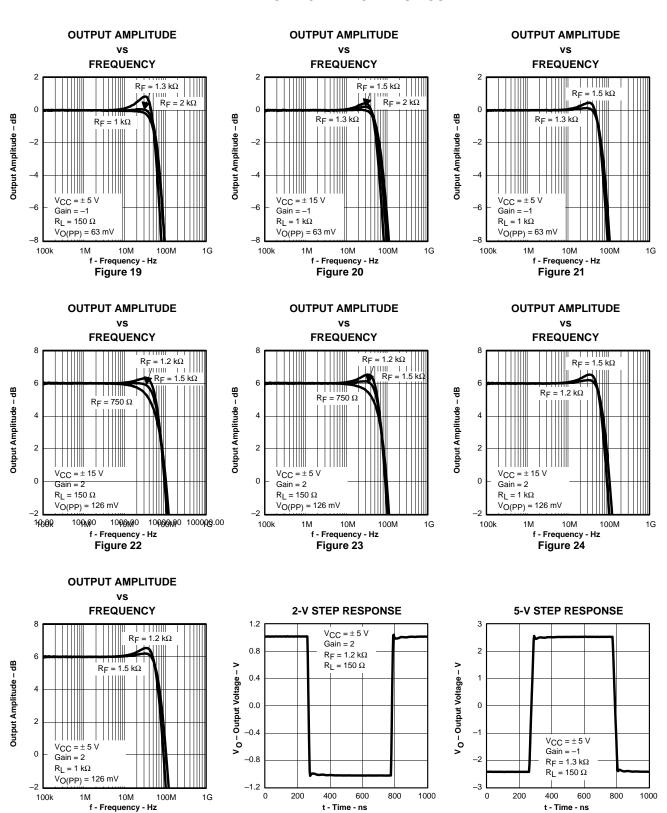
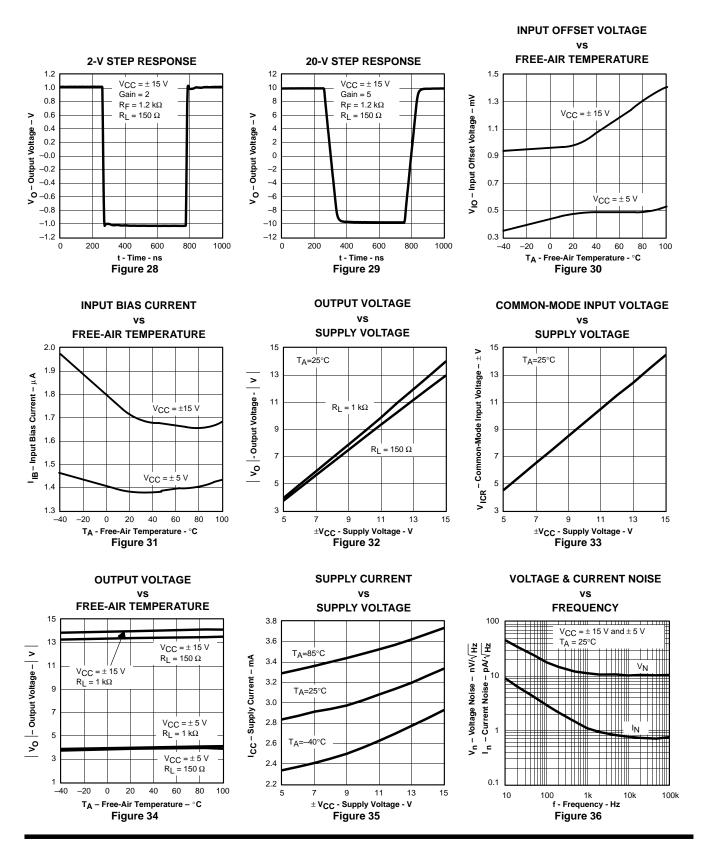




Figure 26

Figure 27

Figure 25



ADSL line noise

Per ANSI T1.413, the noise power spectral density for an ADSL line is $-140 \text{ dBm}/\sqrt{\text{Hz}}$. This results in a voltage noise requirement of less than 31.6 nV/ $\sqrt{\text{Hz}}$ for the receiver in an ADSL system with a 1:1 transformer ratio.

Noise Power Spectral Density = $-140 \text{ dBm}/\sqrt{\text{Hz}}$

Power = $1e-17 \times 1 \text{ Hz} = 0.01 \text{ fW}$

Assume: $R_I = 100 \Omega$

 $V_{\text{noise}} = \sqrt{(P \times R)} = \sqrt{(0.01 \text{ fW} \times 100 \Omega)} = 31.6 \text{ nV}/\sqrt{Hz}$

For ADSL systems that use a 1:2 transformer ratio, such as central office line cards, the voltage noise requirement for the receiver is lowered to 15.8 nV/ $\sqrt{\text{Hz}}$.

TRANSFORMER RATIO	V _{noise} ON LINE
1:1	31.6 nV/√ Hz
1:2	15.8 nV/√Hz

The THS6072 was designed to operate with 10 nV/ $\sqrt{\text{Hz}}$ voltage noise, exceeding the noise requirements for an ADSL system operating with 1:1 or 1:2 transformer ratios. For systems where a voltage noise of less than 10 nV/ $\sqrt{\text{Hz}}$ voltage noise is required, see the THS6062 low noise ADSL receiver which operates with a voltage noise level of 1.6 nV/ $\sqrt{\text{Hz}}$.

minimizing distortion

One way to minimize distortion is to increase the load impedance seen by the amplifier, thereby reducing the currents in the output stage. This will help keep the output transistors in their linear amplification range and will also reduce the heating effects. This can be seen in Figure 10 through Figure 13, which show a 1-k Ω load distortion is much better than a 150- Ω load.



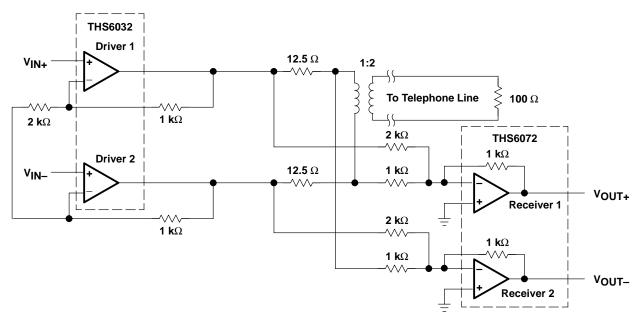


Figure 37. Typical ADSL Central Office Application

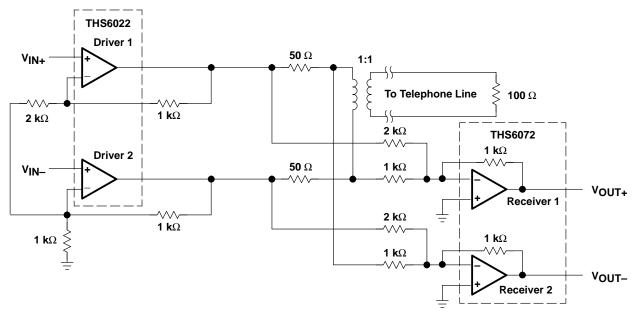


Figure 38. Typical ADSL Remote Terminal Application

theory of operation

The THS6072 is a high-speed, operational amplifier configured in a voltage feedback architecture. It is built using a 30-V, dielectrically isolated, complementary bipolar process with NPN and PNP transistors possessing f_{TS} of several GHz. This results in an exceptionally high performance amplifier that has a wide bandwidth, high slew rate, fast settling time, and low distortion. A simplified schematic is shown in Figure 39.

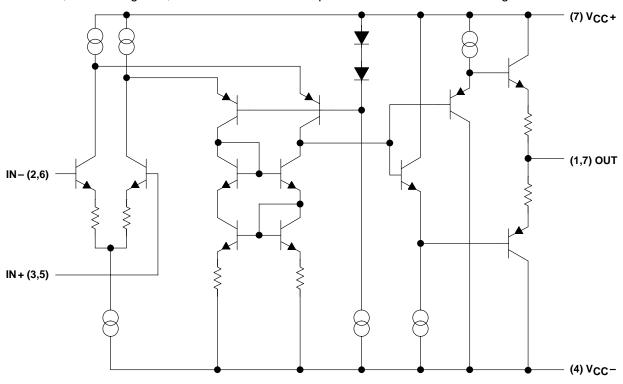


Figure 39. THS6072 Simplified Schematic

noise calculations and noise figure

Noise can cause errors on very small signals. This is especially true when amplifying small signals, where signal-to-noise ratio (SNR) is very important. The noise model for the THS6072 is shown in Figure 40. This model includes all of the noise sources as follows:

- $e_n = Amplifier internal voltage noise (nV/<math>\sqrt{Hz}$)
- IN+ = Noninverting current noise (pA/ $\sqrt{\text{Hz}}$)
- IN- = Inverting current noise (pA/√Hz)
- e_{Rx} = Thermal voltage noise associated with each resistor (e_{Rx} = 4 kTR_x)



noise calculations and noise figure (continued)

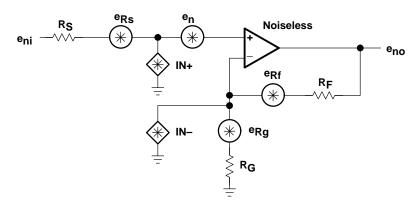


Figure 40. Noise Model

The total equivalent input noise density (eni) is calculated by using the following equation:

$$\mathbf{e}_{ni} = \sqrt{\left(\mathbf{e}_{n}\right)^{2} + \left(\mathsf{IN} + \times \mathsf{R}_{S}\right)^{2} + \left(\mathsf{IN} - \times \left(\mathsf{R}_{F} \, \| \, \mathsf{R}_{G}\right)\right)^{2} + 4 \, \, \mathsf{kTR}_{S} + 4 \, \, \mathsf{kT}\left(\mathsf{R}_{F} \, \| \, \mathsf{R}_{G}\right)}}$$

Where:

 $k = Boltzmann's constant = 1.380658 \times 10^{-23}$

T = Temperature in degrees Kelvin (273 +°C)

 $R_F \parallel R_G = Parallel resistance of R_F and R_G$

To get the equivalent output noise of the amplifier, just multiply the equivalent input noise density (e_{ni}) by the overall amplifier gain (A_V) .

$$e_{no} = e_{ni} A_V = e_{ni} \left(1 + \frac{R_F}{R_G} \right)$$
 (noninverting case)

As the previous equations show, to keep noise at a minimum, small value resistors should be used. As the closed-loop gain is increased (by reducing R_G), the input noise is reduced considerably because of the parallel resistance term. This leads to the general conclusion that the most dominant noise sources are the source resistor (R_S) and the internal amplifier noise voltage (e_n). Because noise is summed in a root-mean-squares method, noise sources smaller than 25% of the largest noise source can be effectively ignored. This can greatly simplify the formula and make noise calculations much easier to calculate.

For more information on noise analysis, please refer to the *Noise Analysis* section in *Operational Amplifier Circuits Applications Report* (literature number SLVA043).

noise calculations and noise figure (continued)

This brings up another noise measurement usually preferred in RF applications, the noise figure (NF). Noise figure is a measure of noise degradation caused by the amplifier. The value of the source resistance must be defined and is typically 50Ω in RF applications.

$$NF = 10log \left[\frac{e_{ni}^{2}}{\left(e_{Rs}\right)^{2}} \right]$$

Because the dominant noise components are generally the source resistance and the internal amplifier noise voltage, we can approximate the noise figure as:

$$NF = 10log \left[1 + \frac{\left(\left(e_n \right)^2 + \left(IN + \times R_S \right)^2 \right)}{4 \text{ kTR}_S} \right]$$

Figure 41 shows the noise figure graph for the THS6072.

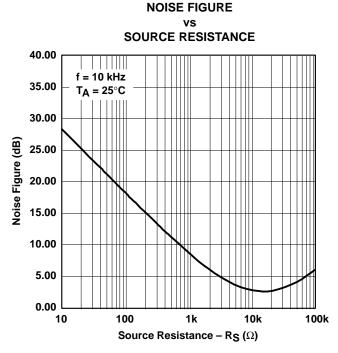


Figure 41. Noise Figure vs Source Resistance



driving a capacitive load

Driving capacitive loads with high performance amplifiers is not a problem as long as certain precautions are taken. The first is to realize that the THS6072 has been internally compensated to maximize its bandwidth and slew rate performance. When the amplifier is compensated in this manner, capacitive loading directly on the output will decrease the device's phase margin leading to high frequency ringing or oscillations. Therefore, for capacitive loads of greater than 10 pF, it is recommended that a resistor be placed in series with the output of the amplifier, as shown in Figure 42. A minimum value of 20 Ω should work well for most applications. For example, in 75- Ω transmission systems, setting the series resistor value to 75 Ω both isolates any capacitance loading and provides the proper line impedance matching at the source end.

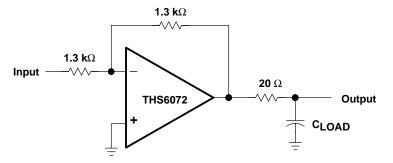


Figure 42. Driving a Capacitive Load

offset voltage

The output offset voltage, (V_{OO}) is the sum of the input offset voltage (V_{IO}) and both input bias currents (I_{IB}) times the corresponding gains. The following schematic and formula can be used to calculate the output offset voltage:

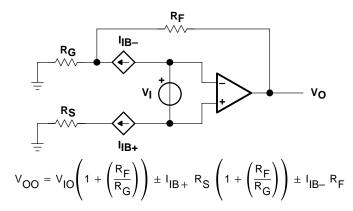


Figure 43. Output Offset Voltage Model

general configurations

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. The simplest way to accomplish this is to place an RC filter at the noninverting terminal of the amplifier (see Figure 44).

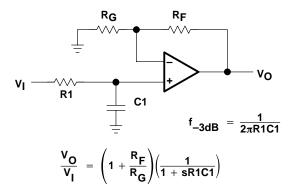


Figure 44. Single-Pole Low-Pass Filter

APPLICATION INFORMATION

circuit layout considerations

To achieve the levels of high frequency performance of the THS6072, follow proper printed-circuit board high frequency design techniques. A general set of guidelines is given below. In addition, a THS6072 evaluation board is available to use as a guide for layout or for evaluating the device performance.

- Ground planes It is highly recommended that a ground plane be used on the board to provide all
 components with a low inductive ground connection. However, in the areas of the amplifier inputs and
 output, the ground plane can be removed to minimize the stray capacitance.
- Proper power supply decoupling Use a 6.8-μF tantalum capacitor in parallel with a 0.1-μF ceramic capacitor on each supply terminal. It may be possible to share the tantalum among several amplifiers depending on the application, but a 0.1-μF ceramic capacitor should always be used on the supply terminal of every amplifier. In addition, the 0.1-μF capacitor should be placed as close as possible to the supply terminal. As this distance increases, the inductance in the connecting trace makes the capacitor less effective. The designer should strive for distances of less than 0.1 inches between the device power terminals and the ceramic capacitors.
- Sockets Sockets are not recommended for high-speed operational amplifiers. The additional lead inductance in the socket pins will often lead to stability problems. Surface-mount packages soldered directly to the printed-circuit board is the best implementation.
- Short trace runs/compact part placements Optimum high frequency performance is achieved when stray series inductance has been minimized. To realize this, the circuit layout should be made as compact as possible, thereby minimizing the length of all trace runs. Particular attention should be paid to the inverting input of the amplifier. Its length should be kept as short as possible. This will help to minimize stray capacitance at the input of the amplifier.
- Surface-mount passive components Using surface-mount passive components is recommended for high
 frequency amplifier circuits for several reasons. First, because of the extremely low lead inductance of
 surface-mount components, the problem with stray series inductance is greatly reduced. Second, the small
 size of surface-mount components naturally leads to a more compact layout, thereby minimizing both stray
 inductance and capacitance. If leaded components are used, it is recommended that the lead lengths be
 kept as short as possible.

general PowerPAD design considerations

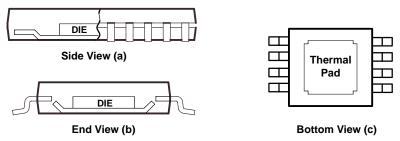
The THS6072 is available packaged in a thermally-enhanced DGN package, which is a member of the PowerPAD family of packages. This package is constructed using a downset leadframe upon which the die is mounted [see Figure 45(a) and Figure 45(b)]. This arrangement results in the lead frame being exposed as a thermal pad on the underside of the package [see Figure 45(c)]. Because this thermal pad has direct thermal contact with the die, excellent thermal performance can be achieved by providing a good thermal path away from the thermal pad.

The PowerPAD package allows for both assembly and thermal management in one manufacturing operation. During the surface-mount solder operation (when the leads are being soldered), the thermal pad can also be soldered to a copper area underneath the package. Through the use of thermal paths within this copper area, heat can be conducted away from the package into either a ground plane or other heat dissipating device.

The PowerPAD package represents a breakthrough in combining the small area and ease of assembly of the surface mount with the, heretofore, awkward mechanical methods of heatsinking.



general PowerPAD design considerations (continued)



NOTE A: The thermal pad is electrically isolated from all terminals in the package.

Figure 45. Views of Thermally Enhanced DGN Package

Although there are many ways to properly heatsink this device, the following steps illustrate the recommended approach.

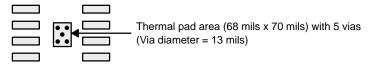


Figure 46. PowerPAD PCB Etch and Via Pattern

- 1. Prepare the PCB with a top side etch pattern as shown in Figure 46. There should be etch for the leads as well as etch for the thermal pad.
- 2. Place five holes in the area of the thermal pad. These holes should be 13 mils in diameter. Keep them small so that solder wicking through the holes is not a problem during reflow.
- 3. Additional vias may be placed anywhere along the thermal plane outside of the thermal pad area. This helps dissipate the heat generated by the THS6072DGN IC. These additional vias may be larger than the 13-mil diameter vias directly under the thermal pad. They can be larger because they are not in the thermal pad area to be soldered, so wicking is not a problem.
- 4. Connect all holes to the internal ground plane.
- 5. When connecting these holes to the ground plane, do not use the typical web or spoke via connection methodology. Web connections have a high thermal resistance connection that is useful for slowing the heat transfer during soldering operations. This makes the soldering of vias that have plane connections easier. In this application, however, low thermal resistance is desired for the most efficient heat transfer. Therefore, the holes under the THS6072DGN package should make their connection to the internal ground plane with a complete connection around the entire circumference of the plated-through hole.
- 6. The top-side solder mask should leave the terminals of the package and the thermal pad area with its five holes exposed. The bottom-side solder mask should cover the five holes of the thermal pad area. This prevents solder from being pulled away from the thermal pad area during the reflow process.
- 7. Apply solder paste to the exposed thermal pad area and all of the IC terminals.
- 8. With these preparatory steps in place, the THS6072DGN IC is simply placed in position and run through the solder reflow operation as any standard surface-mount component. This results in a part that is properly installed.



general PowerPAD design considerations (continued)

The actual thermal performance achieved with the THS6072DGN in its PowerPAD package depends on the application. In the example above, if the size of the internal ground plane is approximately 3 inches \times 3 inches, then the expected thermal coefficient, θ_{JA} , is about 58.4°C/W. For comparison, the non-PowerPAD version of the THS6072 IC (SOIC) is shown. For a given θ_{JA} , the maximum power dissipation is shown in Figure 47 and is calculated by the following formula:

$$\mathsf{P}_\mathsf{D} = \left(\frac{\mathsf{T}_\mathsf{MAX}^{-\mathsf{T}}\mathsf{A}}{\theta_\mathsf{JA}}\right)$$

Where:

P_D = Maximum power dissipation of THS6072 IC (watts)

T_{MAX} = Absolute maximum junction temperature (150°C)

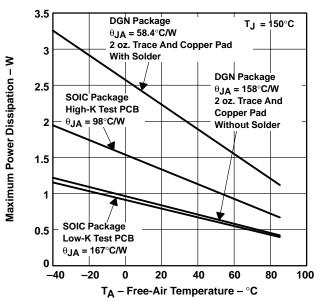
 T_A = Free-ambient air temperature (°C)

 $\theta_{JA} = \theta_{JC} + \theta_{CA}$

 θ_{JC} = Thermal coefficient from junction to case

 θ_{CA} = Thermal coefficient from case to ambient air (°C/W)

MAXIMUM POWER DISSIPATION vs FREE-AIR TEMPERATURE



NOTE A: Results are with no air flow and PCB size = $3"\times 3"$

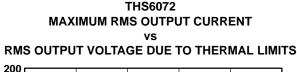
Figure 47. Maximum Power Dissipation vs Free-Air Temperature

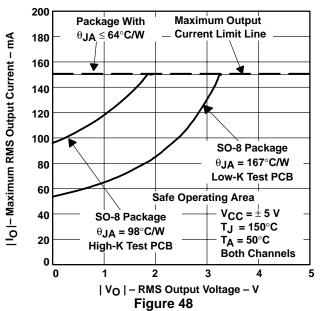
More complete details of the PowerPAD installation process and thermal management techniques can be found in the Texas Instruments Technical Brief, *PowerPAD Thermally Enhanced Package*. This document can be found at the TI web site (www.ti.com) by searching on the key word PowerPAD. The document can also be ordered through your local TI sales office. Refer to literature number SLMA002 when ordering.

general PowerPAD design considerations (continued)

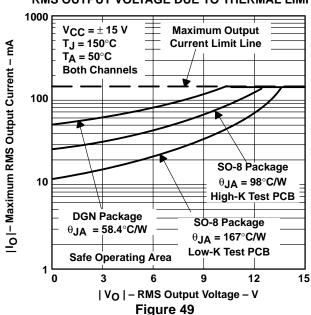
The next consideration is the package constraints. The two sources of heat within an amplifier are quiescent power and output power. The designer should never forget about the quiescent heat generated within the device, especially multiamplifier devices. Because these devices have linear output stages (Class A-B), most of the heat dissipation is at low output voltages with high output currents. Figure 48 and Figure 49 show this effect, along with the guiescent heat, with an ambient air temperature of 50°C. Obviously, as the ambient temperature increases, the limit lines shown will drop accordingly. The area under each respective limit line is considered the safe operating area. Any condition above this line will exceed the amplifier's limits and failure may result. When using $V_{CC} = \pm 5 \text{ V}$, there is generally not a heat problem, even with SOIC packages. But, when

 $V_{CC} = \pm 15 \text{ V}$, the SOIC package is severely limited in the amount of heat it can dissipate. The other key factor when looking at these graphs is how the devices are mounted on the PCB. The PowerPAD devices are extremely useful for heat dissipation. But, the device should always be soldered to a copper plane to fully use the heat dissipation properties of the PowerPAD. The SOIC package, on the other hand, is highly dependent on how it is mounted on the PCB. As more trace and copper area is placed around the device, θ_{IA} decreases and the heat dissipation capability increases. The currents and voltages shown in these graphs are for the total package.





THS6072 **MAXIMUM RMS OUTPUT CURRENT** RMS OUTPUT VOLTAGE DUE TO THERMAL LIMITS



evaluation board

An evaluation board is available for the THS6072 (literature number SLOP322). This board has been configured for very low parasitic capacitance in order to realize the full performance of the amplifier. A schematic of the evaluation board is shown in Figure 50. The circuitry has been designed so that the amplifier may be used in either an inverting or noninverting configuration. For more information, please refer to the *THS6072 EVM User's Guide*. To order the evaluation board, contact your local TI sales office or distributor.

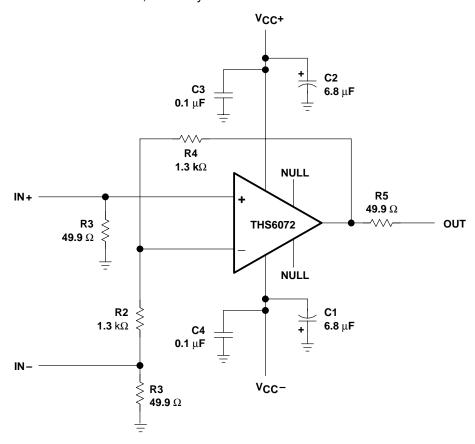


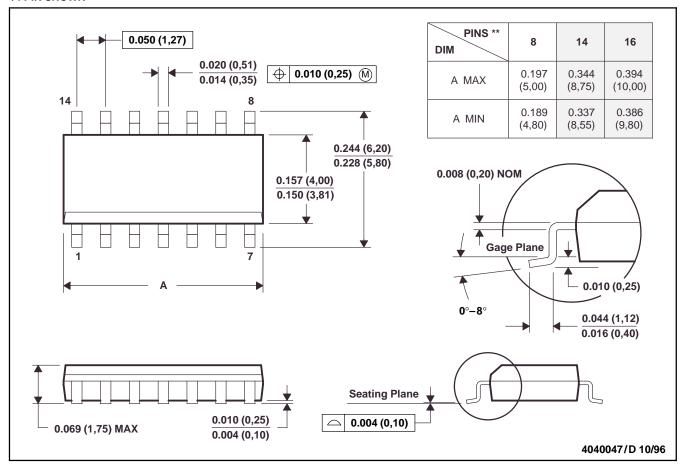
Figure 50. THS6072 Evaluation Board

MECHANICAL INFORMATION

D (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

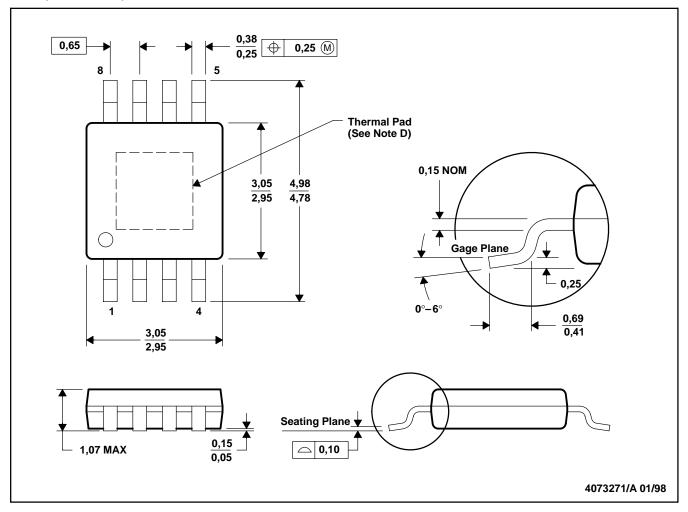
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012



MECHANICAL INFORMATION

DGN (S-PDSO-G8)

PowerPAD™ PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions include mold flash or protrusions.
- D. The package thermal performance may be enhanced by attaching an external heat sink to the thermal pad. This pad is electrically and thermally connected to the backside of the die and possibly selected leads.
- E. Falls within JEDEC MO-187

PowerPAD is a trademark of Texas Instruments.









PACKAGING INFORMATION

	Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
	THS6072CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072CDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072CDGN	ACTIVE	MSOP- Power PAD	DGN	8	80	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072CDGNG4	ACTIVE	MSOP- Power PAD	DGN	8	80	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072CDGNR	ACTIVE	MSOP- Power PAD	DGN	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
Т	HS6072CDGNRG4	ACTIVE	MSOP- Power PAD	DGN	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072CDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072ID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072IDGN	ACTIVE	MSOP- Power PAD	DGN	8	80	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072IDGNG4	ACTIVE	MSOP- Power PAD	DGN	8	80	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072IDGNR	ACTIVE	MSOP- Power PAD	DGN	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
-	THS6072IDGNRG4	ACTIVE	MSOP- Power PAD	DGN	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072IDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
	THS6072IDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



PACKAGE OPTION ADDENDUM

6-Dec-2006

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

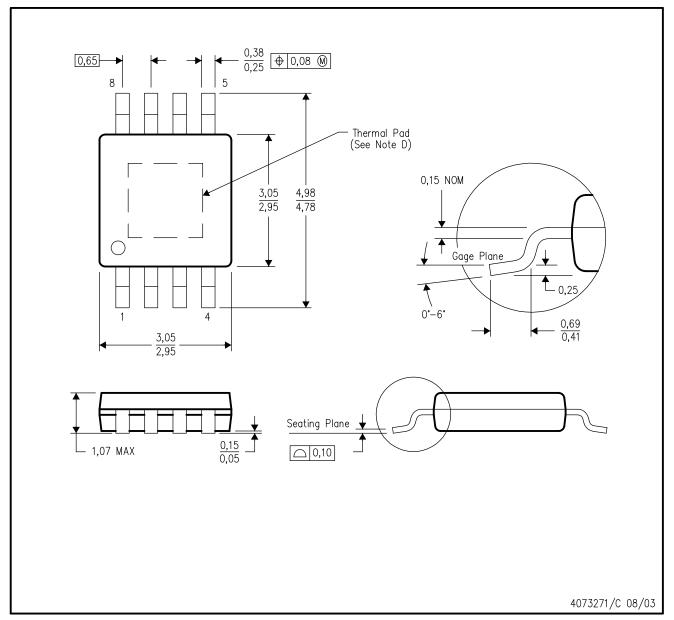
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DGN (S-PDSO-G8)

PowerPAD™ PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- S: A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com https://www.ti.com.
 - E. Falls within JEDEC MO-187

PowerPAD is a trademark of Texas Instruments.



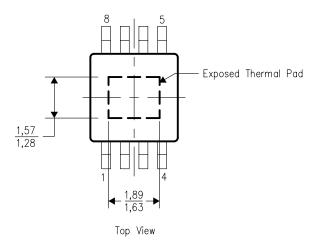


THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. When the thermal pad is soldered directly to the printed circuit board (PCB), the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to a ground or power plane (whichever is applicable), or alternatively, a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

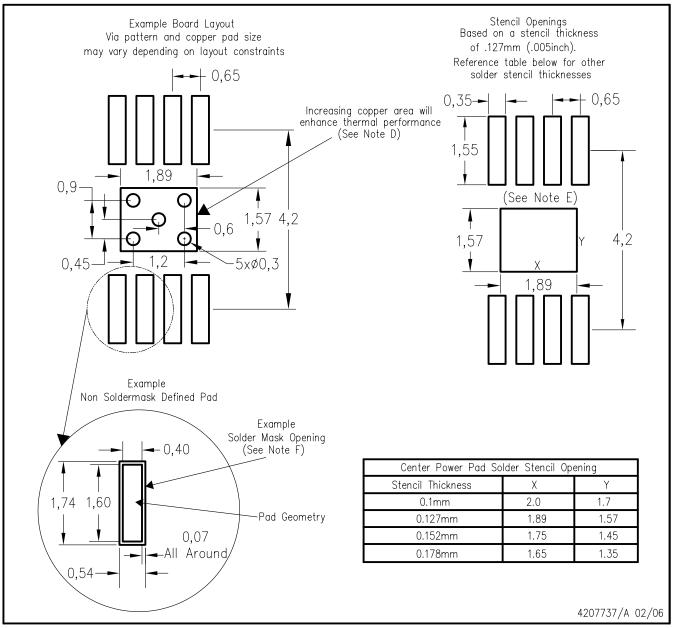
The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters

Exposed Thermal Pad Dimensions

DGN (R-PDSO-G8) PowerPAD™



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AA.



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